

## **30V P-CHANNEL ENHANCEMENT MODE MOSFET**

### **SUMMARY**

V<sub>(BR)DSS</sub> = -30V; R<sub>DS(ON)</sub> = 0.040Ω; I<sub>D</sub> = -6.7A

### DESCRIPTION

This new generation of trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.

### **FEATURES**

- · Low on-resistance
- Fast switching speed
- Low threshold
- Low gate drive
- Low profile SOIC package

### **APPLICATIONS**

- Disconnect switches
- Motor control

## **ORDERING INFORMATION**

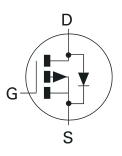
DEVICE	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL
ZXMP3A16N8TA	7″	12mm	500 units
ZXMP3A16N8TC	13″	12mm	2500 units

### **DEVICE MARKING**

 ZXMP 3A16

HI

**SO**8



### PINOUT

1		1
S	0	
S	Single	D
S	Device	D
G		D

Top View



### **ABSOLUTE MAXIMUM RATINGS**

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>DSS</sub>	-30	V
Gate Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current V <sub>GS</sub> =-10V; T <sub>A</sub> =25°C (b) V <sub>GS</sub> =-10V; T <sub>A</sub> =70°C (b) V <sub>GS</sub> =-10V; T <sub>A</sub> =25°C (a)	ID	-6.7 -5.4 -5.6	A
Pulsed Drain Current (c)	I <sub>DM</sub>	-26	А
Continuous Source Current (Body Diode) (b)	I <sub>S</sub>	-3.2	А
Pulsed Source Current (Body Diode) (c)	I <sub>SM</sub>	-26	А
Power Dissipation at T <sub>A</sub> =25°C (a) Linear Derating Factor	P <sub>D</sub>	1.9 15.2	W mW/°C
Power Dissipation at T <sub>A</sub> =25°C (b) Linear Derating Factor	P <sub>D</sub>	2.8 22.4	W mW/°C
Operating and Storage Temperature Range	T <sub>j</sub> :T <sub>stg</sub>	-55 to +150	°C

## THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)	$R_{\theta JA}$	65	°C/W
Junction to Ambient (b)	$R_{\theta JA}$	45	°C/W

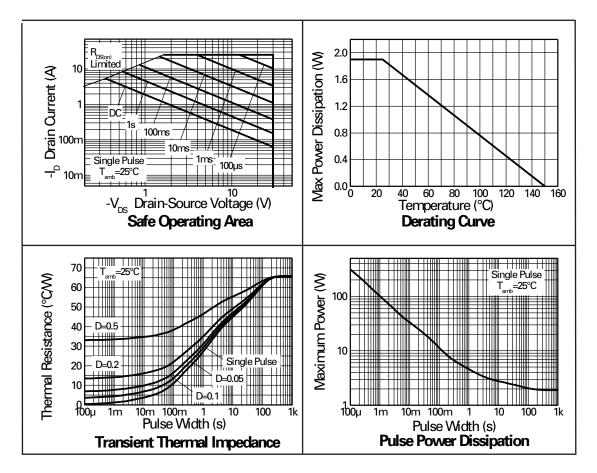
NOTES

(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions

(b) For a device surface mounted on FR4 PCB measured at t≤5 secs.

(c) Repetitive rating 25mm x 25mm FR4 PCB, D = 0.05, pulse width  $10 \mu s$  - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.





## **CHARACTERISTICS**



PARAMETER	SYMBOL	MIN.	TYP.	MAX.		CONDITIONS	
STATIC	STIVIDUL	IVIIIN.	ITF.	IVIAA.	UNIT	CONDITIONS	
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	-30			V	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	00		-1.0	μA	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V	
Gate-Body Leakage	I <sub>GSS</sub>			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	-1.0			V	I <sub>D</sub> =-250μA,V <sub>DS</sub> = V <sub>GS</sub>	
Static Drain-Source On-State Resistance (1)	R <sub>DS(on)</sub>			0.040 0.070	$\Omega$ $\Omega$	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.2A V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.4A	
Forward Transconductance (1)(3)	9 <sub>fs</sub>		9.2		S	V <sub>DS</sub> =-15V,I <sub>D</sub> =-4.2A	
DYNAMIC (3)		-					
Input Capacitance	C <sub>iss</sub>		1022		pF		
Output Capacitance	C <sub>oss</sub>		267		pF	V <sub>DS</sub> =-15 V, V <sub>GS</sub> =0V, f=1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>		229		pF		
SWITCHING(2) (3)		•					
Turn-On Delay Time	t <sub>d(on)</sub>		3.8		ns		
Rise Time	t <sub>r</sub>		6.5		ns	אר	
Turn-Off Delay Time	t <sub>d(off)</sub>		37.1		ns	R <sub>G</sub> =6.0Ω, V <sub>GS</sub> =-10V	
Fall Time	t <sub>f</sub>		21.4		ns		
Gate Charge	Qg		17.2		nC	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-5V, I <sub>D</sub> =-4.2A	
Total Gate Charge	Qg		29.6		nC	-V <sub>DS</sub> =-15V,V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.2A	
Gate-Source Charge	Q <sub>gs</sub>		2.8		nC		
Gate-Drain Charge	Q <sub>gd</sub>		8.6		nC		
SOURCE-DRAIN DIODE							
Diode Forward Voltage (1)	V <sub>SD</sub>		-0.85	-0.95	V	$T_J=25^{\circ}C$ , $I_S=-3.6A$ , $V_{GS}=0V$	
Reverse Recovery Time (3)	t <sub>rr</sub>		21.7		ns	$T_{J}=25^{\circ}C, I_{F}=-2A,$	
Reverse Recovery Charge (3)	Q <sub>rr</sub>		16.1		nC	di/dt= 100A/µs	

# **ELECTRICAL CHARACTERISTICS** (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

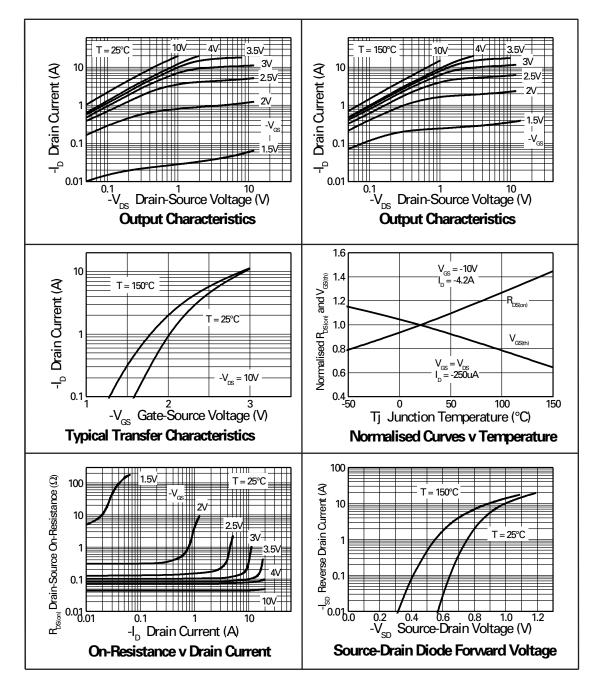
NOTES

(1) Measured under pulsed conditions. Width  ${\leq}300\mu s.$  Duty cycle  ${\leq}~2\%$  .

(2) Switching characteristics are independent of operating junction temperature.

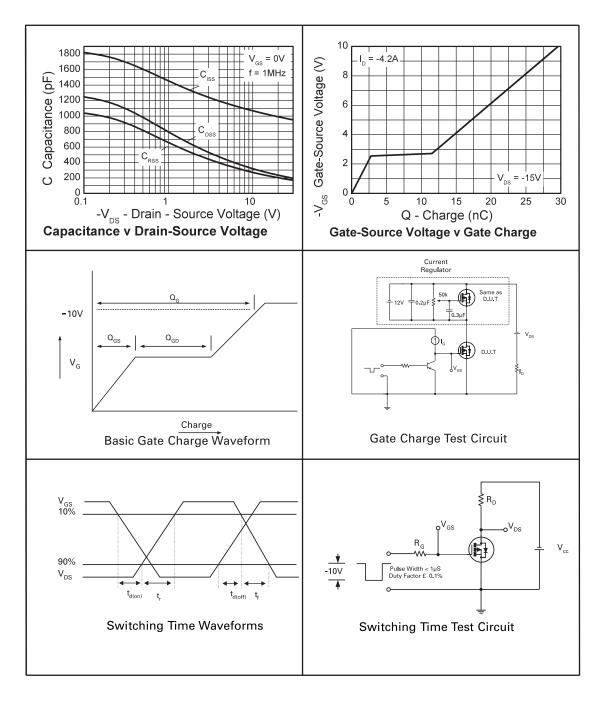
(3) For design aid only, not subject to production testing.





## CHARACTERISTICS





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"Not recommended for new designs"Device is still in production to support existing designs and production

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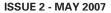
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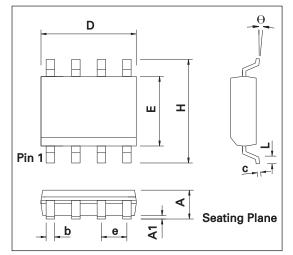
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## PACKAGE OUTLINE



CONTROLLING DIMENSIONS ARE IN INCHES APPROX IN MILLIMETERS

## PACKAGE DIMENSIONS

DIM	Millin	neters	Inc	hes	DIM	Millimeters		Inches	
Dilvi	Min	Мах	Min	Мах		Min	Мах	Min	Max
А	1.35	1.75	0.053	0.069	е	1.27	BSC	0.050	BSC
A1	0.10	0.25	0.004	0.010	b	0.33	0.51	0.013	0.020
D	4.80	5.00	0.189	0.197	с	0.19	0.25	0.008	0.010
Н	5.80	6.20	0.228	0.244	θ	0°	8°	0°	8°
E	3.80	4.00	0.150	0.157	h	0.25	0.50	0.010	0.020
L	0.40	1.27	0.016	0.050	-	-	-	-	-

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